

# **MOSFET** - N-Channel, POWERTRENCH®

**75 V, 49 A, 14.5 m** $\Omega$ 

# **FDMS3500**

## **General Description**

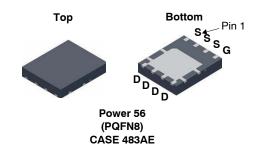
This N-Channel MOSFET is produced using onsemi's advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

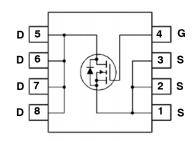
#### **Features**

- Max  $R_{DS(on)} = 14.5 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 11.5 \text{ A}$
- Max  $R_{DS(on)} = 16.3 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 10 \text{ A}$
- Advanced Package and Silicon Combination for Low R<sub>DS(on)</sub>
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

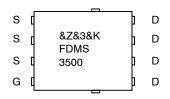
## **Applications**

• DC-DC Conversion





#### **MARKING DIAGRAM**



&Z = Assembly Plant Code &3 = Data Code (Year & Week) &K = Lot

1

FDMS3500 = Specific Device Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
FDMS3500	Power 56 (PQFN8) (Pb-Free / Halogen Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## **MAXIMUM RATINGS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain to Source Voltage	75	V
V <sub>GS</sub>	Gate to Source Voltage	±20	V
I <sub>D</sub>	$ \begin{array}{ll} Drain \ Current: \\ - \ Continuous \ (Package \ Limit) \ T_C = 25^{\circ}C \\ - \ Continuous \ (Silicon \ Limited) \ T_C = 25C \\ - \ Continuous \ T_A = 25^{\circ}C \ (Note \ 1a) \\ - \ Pulsed \end{array} $	49 57 9.2 100	А
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)	384	mJ
P <sub>D</sub>	Power Dissipation: $T_C = 25^{\circ}C$ $T_A = 25^{\circ}C$ (Note 1a)	96 2.5	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	R <sub>θJC</sub> Thermal Resistance, Junction to Case		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

## **ELECTRICAL CHARACTERISTICS** (T<sub>.J</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	75	-	_	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	71	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 60 V	-	-	1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	±100	nA
ON CHARA	CTERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \mu A$	1.0	1.8	3.0	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C	-	-6.8	-	mV/°C
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 11.5 A	-	11.1	14.5	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A	-	12.8	16.3	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 11.5 A, T <sub>J</sub> = 125°C	-	17.6	23.0	
9FS	Forward Transconductance	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 11.5 A	_	56	-	S
DYNAMIC C	HARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	3580	4765	pF
C <sub>oss</sub>	Output Capacitance		_	225	300	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		_	120	175	pF
Rg	Gate Resistance	f = 1 MHz	0.1	1.2	-	Ω

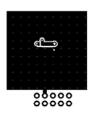
## **ELECTRICAL CHARACTERISTICS** (T<sub>.I</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
SWITCHING	CHARACTERISTICS	•	•	•	•	•
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 40 \text{ V}, I_{D} = 11.5 \text{ A}, V_{GS} = 10 \text{ V},$ $R_{GEN} = 6 \Omega$	_	16	29	ns
t <sub>r</sub>	Rise Time		-	9	18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	7	-	48	77	ns
t <sub>f</sub>	Fall Time	1	-	6	11	ns
Q <sub>g</sub> Total Gate	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V, V <sub>DD</sub> = 40 V, I <sub>D</sub> = 11.5 A	-	65	91	nC
		V <sub>GS</sub> = 0 V to 5 V, V <sub>DD</sub> = 40 V, I <sub>D</sub> = 11.5 A	-	34	48	nC
Q <sub>gs</sub>	Gate to Source Charge	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 44 A	-	9.9	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	7	-	11.6	-	nC
RAIN-SOU	IRCE DIODE CHARACTERISTICS	•				-
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 11.5 A (Note 2)	_	0.8	1.3	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.1 A (Note 2)	-	0.7	1.2	1
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 11.5 A, di/dt = 100 A/μs	-	38	60	ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	45	72	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## NOTES:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5  $\times$  1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300  $\mu s$ , Duty cycle < 2.0%. 3. Starting T<sub>J</sub> = 25°C, L = 3 mH, I<sub>AS</sub> = 16 A, V<sub>DD</sub> = 75 V, V<sub>GS</sub> = 10 V.

#### **TYPICAL CHARACTERISTICS**

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

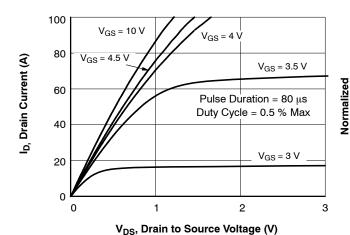


Figure 1. On Region Characteristics

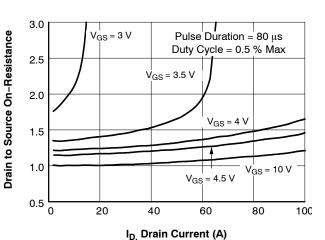


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

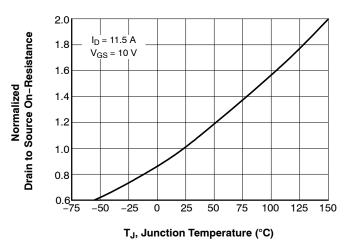


Figure 3. Normalized On Resistance vs. Junction Temperature

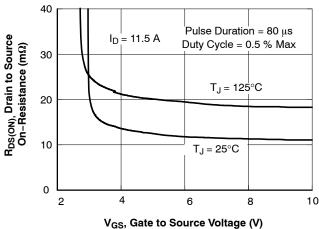


Figure 4. On-Resistance vs. Gate to Source Voltage

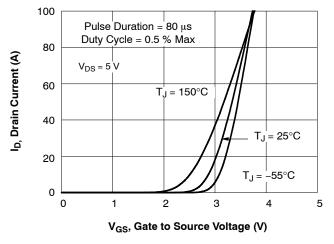


Figure 5. Transfer Characteristics

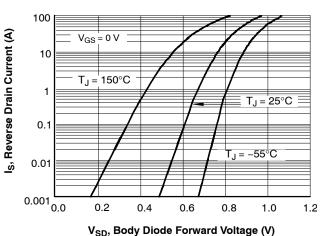


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

## TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

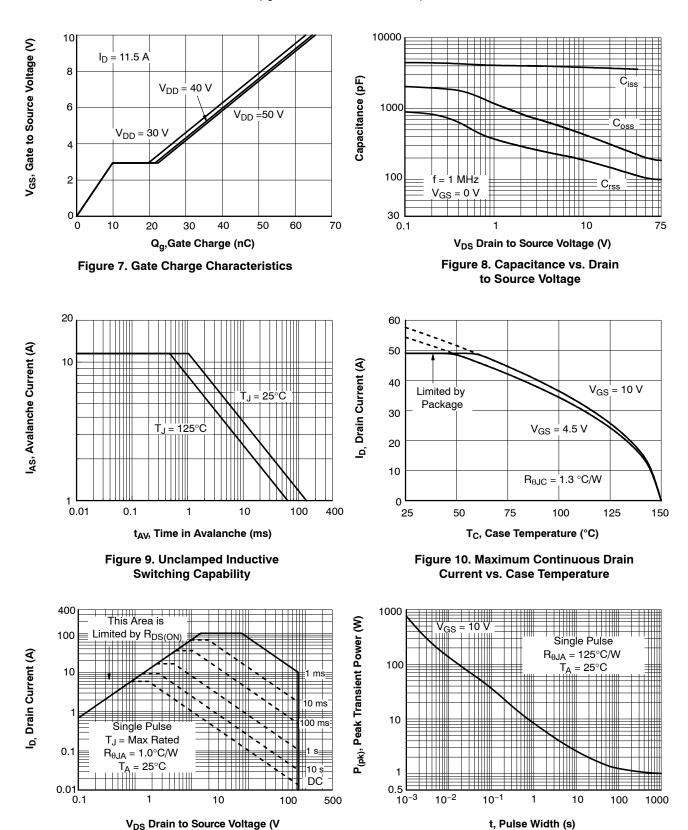
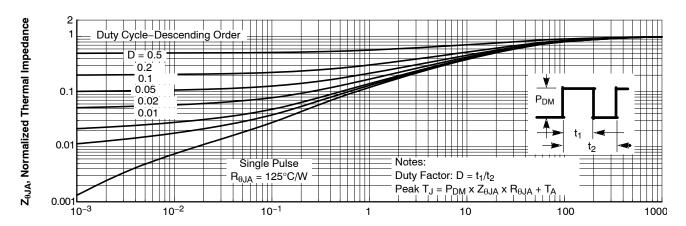


Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation

## TYPICAL CHARACTERISTICS (continued)

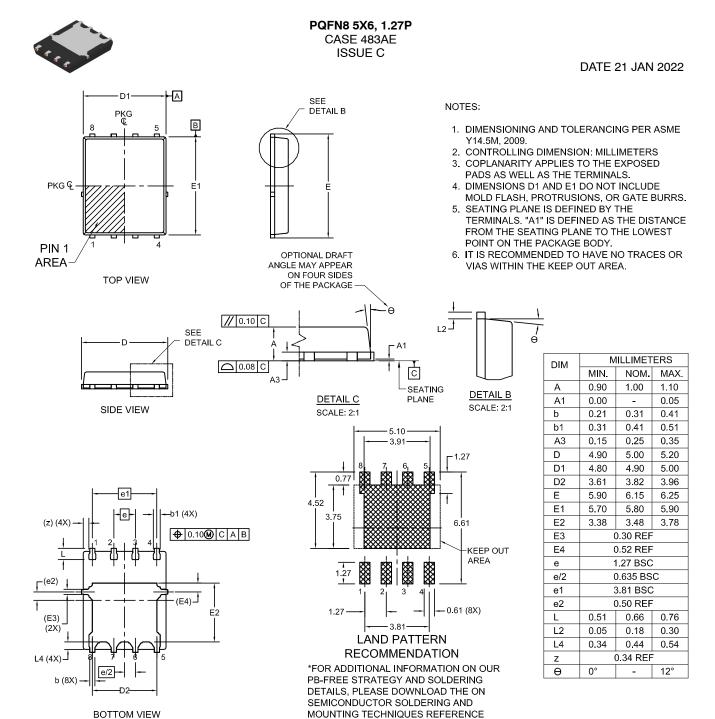
 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 



t, Rectangular Pulse Duration (s)

**Figure 13. Transient Thermal Response Curve** 





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